# Ultra Low Capacitance TSPD

The NPMC series of Low Capacitance Thyristor Surge Protection Devices (TSPD) protect sensitive electronic equipment from transient overvoltage conditions. Due to their ultra low off-state capacitance ( $C_o$ ), they offer minimal signal distortion for high speed equipment such as DSL and T1/E1 circuits. The low nominal offstate capacitance translates into the extremely low differential capacitance offering superb linearity with applied voltage or frequency.

The NPMC Series helps designers to comply with the various regulatory standards and recommendations including: GR-1089-CORE, IEC 61000-4-5, ITU K.20/K.21/K.45, IEC 60950, TIA-968-A, FCC Part 68, EN 60950, UL 1950.

#### Features

- Ultra Low Micro Capacitance
- Low Leakage (Transparent)
- High Surge Current Capabilities
- Precise Turn on Voltages
- Low Voltage Overshoot
- These are Pb–Free Devices

#### **Typical Applications**

- xDSL Central Office and Customer Premise
- T1/E1
- Other Broadband High Speed Data Transmission Equipment

#### ELECTRICAL PARAMETERS

	V <sub>DRM</sub>	V <sub>(BO)</sub>	VT	I <sub>DRM</sub>	I <sub>(BO)</sub>	Ι <sub>Τ</sub>	Ι <sub>Η</sub>
Device	V	V	v	μΑ	mA	Α	mA
NP0640SxMCT3G	58	77	4	5	800	2.2	150
NP0720SxMCT3G	65	88	4	5	800	2.2	150
NP0900SxMCT3G	75	98	4	5	800	2.2	150
NP1100SxMCT3G	90	130	4	5	800	2.2	150
NP1300SxMCT3G	120	160	4	5	800	2.2	150
NP1500SxMCT3G	140	180	4	5	800	2.2	150
NP1800SxMCT3G	170	220	4	5	800	2.2	150
NP2100SxMCT3G	180	240	4	5	800	2.2	150
NP2300SxMCT3G	190	260	4	5	800	2.2	150
NP2600SxMCT3G	220	300	4	5	800	2.2	150
NP3100SxMCT3G	275	350	4	5	800	2.2	150
NP3500SxMCT3G	320	400	4	5	800	2.2	150

G = indicates leadfree, RoHS compliant

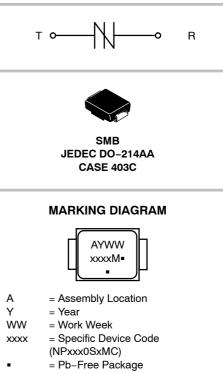
\*91 Recognized Components



# **ON Semiconductor®**

http://onsemi.com

# ULTRA LOW CAPACITANCE BIDIRECTIONAL SURFACE MOUNT THYRISTOR 64 – 350 VOLTS



(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NPxxx0SxMCT3G	SMB (Pb–Free)	2500 Tape & Reel

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### **TEL-COM STANDARDS**

	Wave	eform	x = series ratings			
Specification	Voltage (µs)	Current (µs)	Α	В	С	Unit
GR-1089-CORE	2x10	2x10	150	250	500	A(pk)
TIA-968-A	10x160	10x160	90	150	200	
GR-1089-CORE	10x360	10x360	75	125	175	
TIA-968-A	10x560	10x560	50	100	150	
ITU-T K.20/21	10x700	5x310	75	100	200	
GR-1089-CORE	10x1000	10x1000	50	80	100	

#### SURGE RATINGS

Characteristics	Symbol	Α	В	С	Unit
Nominal Pulse Surge Short Circuit Current Non – Repetitive Double Exponential Decay Waveform (Notes 1, 2 and 3) 2 × 10 μSec 8 × 20 μSec 10 × 160 μSec 10 × 360 μSec 10 × 560 μSec 10 × 700 μSec 10 × 1000 μSec	IPPS1 IPPS2 IPPS3 IPPS5 IPPS5 IPPS6 IPPS7	150 150 90 75 50 75 50	250 250 150 125 100 100 80	500 400 200 150 150 200 100	A(pk)

Allow cooling before testing second polarity.
Measured under pulse conditions to reduce heating.
Nominal values may not represent the maximum capability of a device.

#### CAPACITANCE

				Max		
Characteristic	S	Symbol	Α	В	С	Unit
(f=1.0 MHz, 1.0 V <sub>rms</sub> , 2 Vdc bias) (C <sub>o</sub> Apx 45% @ 50 V)	NP0640SxMCT3G NP0720SxMCT3G NP0900SxMCT3G NP1100SxMCT3G NP1300SxMCT3G NP1500SxMCT3G NP1800SxMCT3G NP2100SxMCT3G NP2300SxMCT3G NP2600SxMCT3G NP3100SxMCT3G NP3500SxMCT3G	Co	23 23 23 23 23 23 23 23 23 23 23 23 23 2	29 29 29 29 29 29 29 29 29 29 29 29 29 2	33 33 33 33 33 33 33 33 33 33 33 33 33	pF

#### **MAXIMUM RATINGS** (T<sub>A</sub> = $25^{\circ}$ C unless otherwise noted)

Symbol	Rating		Value	Unit
V <sub>DRM</sub>	Repetitive peak off-state voltage: Rated maximum	NP0640SxMCT3G	±58	V
	(peak) continuous voltage that may be applied in the off-state conditions including all dc and repetitive	NP0720SxMCT3G	±65	
	alternating voltage components.	NP0900SxMCT3G	±75	
		NP1100SxMCT3G	±90	
		NP1300SxMCT3G	±120	
		NP1500SxMCT3G	±140	
		NP1800SxMCT3G	±170	
		NP2100SxMCT3G	±180	
	(Stresses exceeding Maximum Ratings may damage	NP2300SxMCT3G	±190	
	the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended	NP2600SxMCT3G	±220	
	Operating Conditions is not implied. Extended exposure to stresses above the Recommended	NP3100SxMCT3G	±275	
	Operating Conditions may affect device reliability.)	NP3500SxMCT3G	±320	

Symbol	Rating		Min	Тур	Max	Unit
V <sub>(BO)</sub>	Breakover voltage: The maximum voltage across the device in or at the	NP0640SxMCT3G			±77	V
	breakdown region. (Note 4) VDC = 1000 V, dv/dt = 100 V/μs	NP0720SxMCT3G			±88	1
		NP0900SxMCT3G			±98	l
		NP1100SxMCT3G			±130	1
		NP1300SxMCT3G			±160	1
		NP1500SxMCT3G			±180	1
		NP1800SxMCT3G			±220	1
		NP2100SxMCT3G			±240	1
		NP2300SxMCT3G			±260	l
		NP2600SxMCT3G			±300	l
		NP3100SxMCT3G			±350	1
		NP3500SxMCT3G			±400	1
I <sub>(BO)</sub>	Breakover Current: The instantaneous current flowing at the breakover v	oltage.			800	mA
Ι <sub>Η</sub>	Holding Current: Minimum current required to maintain the device in the	on-state. (Notes 5, 6)	150			mA
I <sub>DRM</sub>	Off-state Current: The dc value of current that results from the applica-	V <sub>D</sub> = 50 V			2	μA
	tion of the off-state voltage	$V_D = V_{DRM}$			5	l
V <sub>T</sub>	On–state Voltage: The voltage across the device in the on–state conditio $I_T$ = 2.2 A (pk), PW = 300 $\mu s,$ DC = 2%	n.			4	V
di/dt	Critical rate of rise of on-state current: rated value of the rate of rise of cu can withstand without damage.	urrent which the device			±500	A/μs

#### **ELECTRICAL CHARACTERISTICS TABLE** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Electrical parameters are based on pulsed test methods.
Measured under pulsed conditions to reduce heating
Allow cooling before testing second polarity.

#### **THERMAL CHARACTERISTICS**

Symbol	Rating	Value	Unit
T <sub>STG</sub>	Storage Temperature Range	–65 to +150	°C
TJ	Junction Temperature	-40 to +150	°C
R <sub>0JA</sub>	Thermal Resistance: Junction-to-Ambient Per EIA/JESD51-3, PCB = FR4 3"x4.5"x0.06" Fan out in a 3x3 inch pattern, 2 oz copper track.	90	°C/W

Symbol	Parameter
V <sub>DRM</sub>	Repetitive Peak Off-state Voltage
V <sub>(BO)</sub>	Breakover Voltage
I <sub>DRM</sub>	Off-state Current
I <sub>(BO)</sub>	Breakover Current
Ι <sub>Η</sub>	Holding Current
V <sub>T</sub>	On-state Voltage
Ι <sub>Τ</sub>	On-state Current
I <sub>TSM</sub>	Nonrepetitive Peak On-state Current
I <sub>PPS</sub>	Nonrepetitive Peak Impulse Current
V <sub>D</sub>	Off-state Voltage
۱ <sub>D</sub>	Off-state Current

#### ELECTRICAL PARAMETER/RATINGS DEFINITIONS

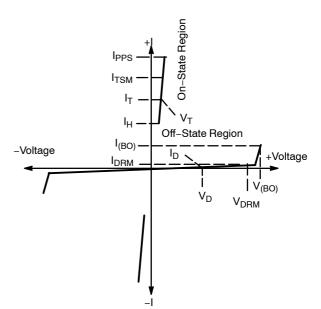


Figure 1. Voltage Current Characteristics of TSPD

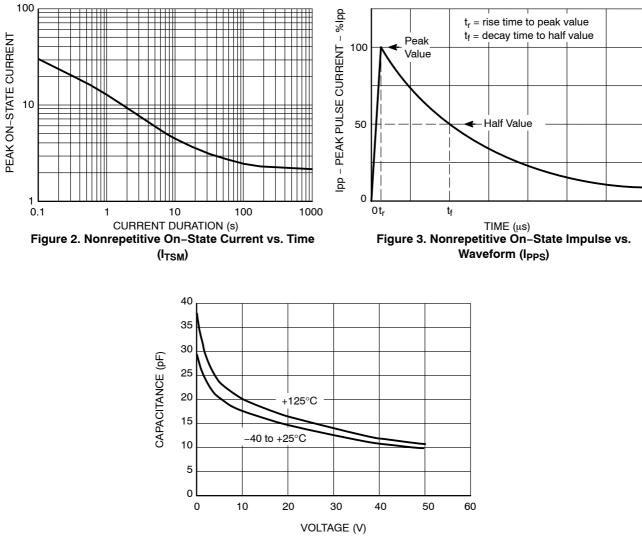


Figure 4. Capacitance vs. Off-State Voltage

#### **Detailed Operating Description**

The TSPD or <u>Thyristor Surge Protection Device</u> are specialized silicon based overvoltage protectors, used to protect sensitive electronic circuits from damaging overvoltage transient surges caused by induced lightning and powercross conditions.

The TSPD protects by switching to a low on state voltage when the specified protection voltage is exceeded. This is known as a "crowbar" effect. When an overvoltage occurs, the crowbar device changes from a high–impedance to a low–impedance state. This low–impedance state then offers a path to ground, shunting unwanted surges away from the sensitive circuits.

This crowbar action defines the TSPD's two states of functionality: Open Circuit and Short Circuit.

<u>Open Circuit</u> – The TSPD must remain transparent during normal circuit operation. The device looks like an open across the two wire line.

<u>Short Circuit</u> – When a transient surge fault exceeds the TSPD protection voltage threshold, the devices switches on, and shorts the transient to ground, safely protecting the circuit.



Normal Circuit Operation





The electrical characteristics of the TSPD help the user to define the protection threshold for the circuit. During the open circuit condition the device must remain transparent; this is defined by the  $I_{DRM}$ . The  $I_{DRM}$  should be as low as possible. The typical value is less than 5  $\mu$ A.

The circuit operating voltage and protection voltage must be understood and considered during circuit design. The V<sub>(BO)</sub> is the guaranteed maximum voltage that the protected circuit will see, this is also known as the protection voltage. The V<sub>DRM</sub> is the guaranteed maximum voltage that will keep the TSPD in its normal open circuit state. The TSPD V<sub>(BO)</sub> is typically a 20–30% higher than the V<sub>DRM</sub>. Based on these characteristics it is critical to choose devices which have a V<sub>DRM</sub> higher than the normal circuit operating voltage, and a V<sub>(BO)</sub> which is less than the failure threshold of the protected equipment circuit. A low on–state voltage V<sub>t</sub> allows the TSPD to conduct large amounts of surge current (500 A) in a small package size.

Once a transient surge has passed and the operating voltage and currents have dropped to their normal level the TSPD changes back to its open circuit state.

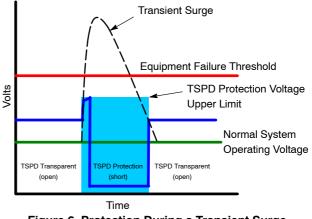


Figure 6. Protection During a Transient Surge

TSPD's are useful in helping designers meet safety and regulatory standards in Telecom equipment including GR-1089-CORE, ITU-K.20, ITU-K.21, ITU-K.45, FCC Part 68, UL1950, and EN 60950.

ON Semiconductor offers a full range of these products in the NP series product line.

#### DEVICE SELECTION

When selecting a TSPD use the following key selection parameters.

#### Off-State Voltage VDRM

Choose a TSPD that has an Off–State Voltage greater than the normal system operating voltage. The protector should not operate under these conditions:

Example:

#### Vbat = 48 Vmax

 $V_{\mbox{\scriptsize DRM}}$  should be greater than the peak value of these two components:

 $V_{DRM} > 212 + 48 = 260 V_{DRM}$ 

#### Breakover Voltage V(BO)

Verify that the TSPD Breakover Voltage is a value less than the peak voltage rating of the circuit it is protecting.

Example: Relay breakdown voltage, SLIC maximum voltage, or coupling capacitor maximum rated voltage.

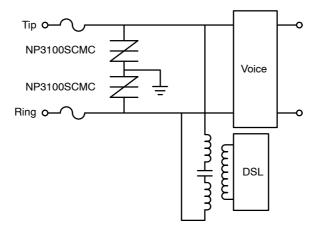
#### Peak Pulse Current Ipps

Choose a Peak Pulse current value which will exceed the anticipated surge currents in testing. In some cases the 100 A "C" series device may be needed when little or no series resistance is used. When a series current limiter is used in the circuit a lower current level of "A" or "B" may be used. To determine the peak current divide the maximum surge current by the series resistance.

#### Hold Current (I<sub>H</sub>)

The Hold Current must be greater than the maximum system generated current. If it is not then the TSPD will remain in a shorted condition, even after a transient event has passed.

# **TYPICAL APPLICATIONS**





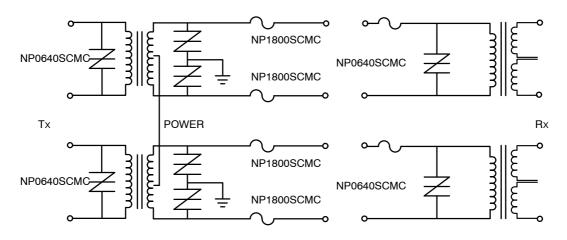


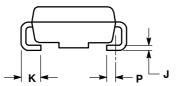
Figure 8. T1/E1

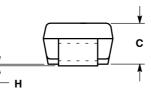
#### PACKAGE DIMENSIONS

SMB

**ISSUE A** 

CASE 403C-01 s Α D B





NOTES:

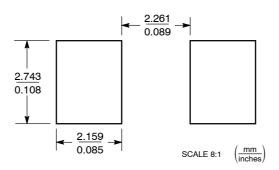
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982.

2. CONTROLLING DIMENSION: INCH. 3. D DIMENSION SHALL BE MEASURED WITHIN

DIMENSION P.

	INC	HES	MILLIN	IETERS
DIM	MIN MAX		MIN	MAX
Α	0.160	0.180	4.06	4.57
В	0.130	0.150	3.30	3.81
С	0.075	0.095	1.90	2.41
D	0.077	0.083	1.96	2.11
Н	0.0020	0.0060	0.051	0.152
J	0.006	0.012	0.15	0.30
Κ	0.030	0.050	0.76	1.27
Ρ	0.020 REF		0.51	REF
S	0.205	0.220	5.21	5.59

#### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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